

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







Issue No.	:	151EXB008057

Date of Issue: November 26.2008

Classification : ■ New □ Changed

DIGI-KEY CORPORATION

PRODUCT SPECIFICATION FOR APPROVAL

Product Description : Chip Resistor Array (RoHS Compliance)

Product Part Number : $EXBV8V***\square V$

Country of Origin : JAPAN, CHINA, MALAYSIA
Applications : Standard electronic equipment

*If you approve this specification, please fill in and sign the below and return 1 copy to us.

Approval No :

Approval Date :

Executed by :

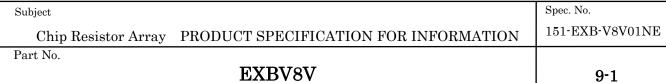
(signature)

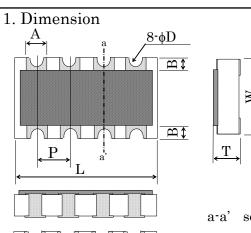
Title :
Dept. :

Circuit Components Business Unit Panasonic Electronic Devices Co., Ltd.

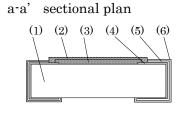
401 Sadamasa-cho, Fukui City 910-8502 Japan

Phone: +81-776-56-8034 Fax: +81-776-56-3114 





(1)Substrate	(2)Protective	(3)Resistive
(1)Substrate	coating	element
Alumina	Resin	Ruthenium oxide
(4)Termination	(5)Termination	(6) Termination
(Inner)	(Between)	(Outer)
Ag or Ag/Pd	Ni Plating	Sn Plating

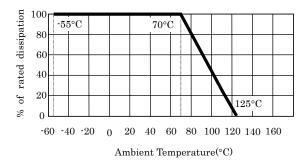


	L	W	Т	A	В
Dimension(mm)	3.20 +0.20 -0.10	1.60 +0.20 -0.10	0.60±0.10	0.60±0.10	0.30±0.15

	D	P	E	G
Dimension(mm)	(0.30)	(0.80)	0.45 ± 0.10	0.45 ± 0.15

(): Reference

2. Power derating curve



 $Category\ temperature\ range$

-55°C to +125°C

Fig. 1

3. Ratings

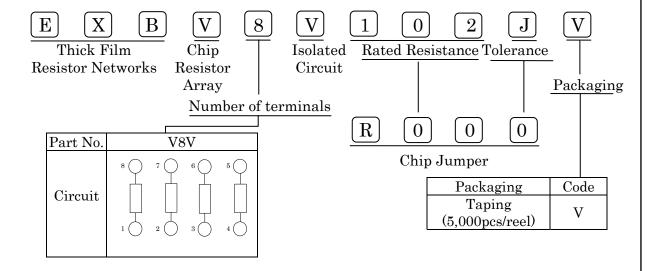
 \mathbf{E}_{\cdot}

Item	Rated Value	Explanation			
Rated Dissipation	0.063 W / element	When used at ambient temperature over 70 °C, the rated dissipation should be reduced as shown in Fig.1			
	Chip jumper: Rated current 1 A (Resistance is less than 50 mΩ)				
Rated voltage & Rated Continuous Working Voltage	The rated voltage of each resistor should be calculated from equation below, and when the rated voltage exceeds the limit element voltage, the limiting element voltage should the maxin working voltage.				
(RCWV)	$E = \sqrt{P \times R}$ E: Rated voltage(V	Limiting element voltage : 50 V V), P: Rated dissipation(W), R: Rated resistance(Ω)			

Subject		Spec. No.
Chip Resistor Array PROD	UCT SPECIFICATION FOR INFORMATION	151-EXB-V8V01NE
Part No.		
	EXBV8V	9-2

Item	Rated Value	Explanation				
Maximum overload voltage	Voltage should be $2.5 \times E$. When the voltage exceeds the maximum overload voltage, the value shown below should be the maximum overload voltage. Maximum overload voltage: $100V$ Chip jumper: Max. overload current $2A$					
Resistance tolerance						
Range of rated resistance for manufacture	Tolerance J 0	Resistance range $1.0~\Omega$ to $1.0~\mathrm{M}\Omega$ Less than $50~\mathrm{m}\Omega$	Series E-24			

4. Explanation of part number



5. Appearance & Construction

Item	Specifications	Explanation
Appearance & Construction	that do not far unevenness, fla 2. The electrode dimensions. The unevenness, fla 3. The electrode of resistive elements. Substrate should	dement should be covered with protective coating ade easily. The surface of coating should avoid aw, pinhole and discoloration. should be printed uniformly, as shown in the deplating should not fade easily, and should avoid aw, pinhole, projection and discoloration. Should be connected electrically, mechanically to not. In the discoloration and discoloration are connected electrically, mechanically to not. In the discoloration are connected electrically, mechanically to not have chipping, flaw, flash and crack. Details criteria shall be as described in attached sheet

Subject	Spec. No.
Chip Resistor Array PRODUCT SPECIFICATION FOR I	NFORMATION 151-EXB-V8V01NE
Part No.	
EXBV8V	9-3

As far as there shall be not designation especially, the following test and measurement shall be operated under normal temperature (15 °C to 35 °C), normal humidity (25 %RH to 75 %RH), normal atmospheric pressure (86 kPa to 106 kPa).

6. Performance Specification

pecification		
Specification Specification		Test methods
Resistor	Jumper	1 est methods
DC resistance value shall be within the specified tolerance	Less than 50 mΩ	Measuring voltage: refer to JIS-C5201-1 At 20 °C, 65 %RH
Resistance	TCR	Natural resistance change per temperature degree centigrade.
<10Ω	+600 ×10-6 / °C	$TCR = \frac{R_2 - R_1}{R_1 \times (t_2 - t_1)}$
10Ω to $1M\Omega$	±200×10 ⁻⁶ / °C	R_1 : Resistance value at reference
coefficient Chip jumper:		$temperature(t_1)$
		R_2 : Resistance value at test
1 0 1	n $50~\mathrm{m}\Omega$	$temperature(t_2)$
		$t_2 \cdot t_1 = 100 ^{\circ}\text{C}, t_1 = 25 ^{\circ}\text{C}$
±(2 %+0.1 Ω)	Less than	Resistors shall be applied 2.5 times the rated voltage for 5 seconds.
	00 11122	Maximum over load voltage shall be 100 V.
±(5 %+0.1 Ω)	Less than 50 mΩ	Resistors shall be subjected to 10000 cycles of 2.5 times the rated voltage applied for 1 second with pause of 25 seconds between tests. Maximum over load voltage shall be 100 V
Dielectric No evidence of flashover, mechanical damage, arcing or		AC 100V between substrate and termination
		for 1 minute.
insulation break	down.	
Min. 1,000 MΩ		Insulation resistance between substrate and
		termination shall be measured at DC 100V.
	Specification Resistor DC resistance value shall be within the specified tolerance Resistance $<10\Omega$ 10Ω to $1M\Omega$ Chip jumper: Less that $\pm(2~\%+0.1~\Omega)$ No evidence of fl mechanical dama insulation break	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

7. Mechanical characteristic

Item	Specification		Test methods
Item	Resistor	Jumper	Test methods
Bend strength of	No mechanical dar	nage	Substrate: Glass epoxy(t = 1.6 mm) Span: 90 mm
the face plating	±(1 %+0.05 Ω)	Less than $50~\mathrm{m}\Omega$	Bending distance: 3 mm (10 seconds)
Solderability	Termination shou uniformly with sol (min. 95 % coverag	aer.	Resistors shall be dipped in the melted solder bath at 235 °C \pm 5 °C for 2 s \pm 0.5 s. Flux shall be removed from the surface of termination with clean organic solvent.

Subject		Spec. No.
Chip Resistor Array PR	RODUCT SPECIFICATION FOR INFORMATION	151-EXB-V8V01NE
Part No.		
	EXBV8V	9-4

Thomas	Specification		Test methods	
Item Resistor Jumper		Jumper		
Resistance to	±(1 %+0.05 Ω)	Less than	Resistors shall be dipped in the melted solder	
soldering heat	±(1 %+0.03 \\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	$50~\mathrm{m}\Omega$	bath at 270 °C \pm 5 °C for 10s \pm 1s.	
Vibration	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be subjected to a single vibration having as double amplitude of 1.5 mm for 2 hours in each three mutually perpendicular directions for total 6 hours. The vibration frequency shall be varied uniformly 10 Hz to 55 Hz and return to 10 Hz traversing for 1 minute.	
	Without distinct deformation in		Solvent solution: Isopropyl alcohol	
	appearance		(1) Dipping 10 hours \pm 1 hour, dry in room	
Solvent resistance	±(0.5 %+0.05 Ω)	Less than 50 mΩ	condition for 30 min ± 10 min. (2) Ultrasonic wave washing: 5 min ± 1 min (0.3 W/cm²,28 kHz) Dry in room condition for 30 min ± 10 min.	

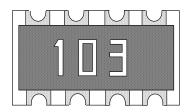
8. Environmental Test

6. Environmental Test				
Item	Specification		Test methods	
rtein	Resistor	Jumper	Test methods	
Low temperature	1 (1 0/ 1 0 0 ° O)	Less than	Resistors shall be exposed at -55 °C \pm 3 °C for	
exposure	$\pm (1 \% + 0.05 \Omega)$	$50~\mathrm{m}\Omega$	$1000 \text{ hours} \stackrel{+48}{0} \text{ hours}$	
Endurance at upper		Loggithou	Resistors shall be exposed at +125 °C±3 °C for	
category	$\pm (1 \% + 0.05 \Omega)$	Less than	$1000 \text{ hours} \stackrel{+48}{0} \text{ hours}.$	
temperature		$50~\mathrm{m}\Omega$		
Temperature cycling	±(1 %+0.05 Ω)	Less than $50~\text{m}\Omega$	-55 °C ± 3 °C, 30 minutes ↑↓ Nominal temp., 30minutes 25cycles ↑↓ +125 °C ± 3 °C, 30minutes	
Humidity (Steady state)	±(1 %+0.05 Ω)	Less than $50 \text{ m}\Omega$	Registers shall be exposed at 60 °C + 2 °C as	
Endurance at 70 °C	±(3 %+0.1 Ω)	Less than 50 mΩ	Resistors shall be exposed at 70 °C \pm 2 °C 1000 hours $_0^{+48}$ hours. During this time, rated voltage shall be applied intermitten for 1.5 hours ON, 0.5 hour OFF.	
Load life in humidity	±(3 %+0.1 Ω)	Less than 50 mΩ	Resistor shall be exposed at 60 °C \pm 2 °C an 90 % to 95 % relative humidity for 1000 hour $^{+48}_{0}$ hours. During this time, the rated voltag shall be applied intermittently for 1.5 hour ON, 0.5 hour OFF.	

Subject	S	Spec. No.
Chip Resistor Array PRODUCT SI	PECIFICATION FOR INFORMATION 1	151-EXB-V8V01NE
Part No.		
EXI	BV8V	9-5

9. Resistance value marking

Express resistance value on resin side with three digits.



(Example)

 $103 \rightarrow 10 \ \mathrm{k}\Omega$ The first two digits should be significant figures of resistance for E-24 series and the third one denotes number of zeros in ohms.

 $000 \rightarrow \text{Chip jumper}$

Subject	Spec. No.
Chip Resistor Array PRODUCT SPECIFICATION FOR INFORMATION	151-EXB-V8V01NE
Part No.	
EXBV8V	9-6

10. Notice for use



Notice for use

- (1) This specification shows the quality and performance of the product in a unit component. Before adoption, be sure to evaluate and verify the product mounting it in your product.
- (2)We take no responsibility for troubles caused by the product usage that is not specified in this specification.
- (3)In traffic transportation equipment (trains, cars, traffic signal equipment, etc.), medical equipment, aerospace equipment, electric heating appliances, combustion and gas equipment, rotating equipment, disaster and crime preventive equipment, etc. in cases where it is forecast that the failure of this product gives serious damage to human life and others, use fail-safe design and ensure safety by studying the following items to
 - Ensure safety as the system by setting protective circuits and protective equipment.
 - ◆ Ensure safety as the system by setting such redundant circuits as do not cause danger by a single failure.
- (4) When a dogma shall be occurred about safety for this product, be sure to inform us rapidly, operate your technical examination.
- (5) The product is designed to use in general standard applications of general electric equipment (AV products, household electric appliances, office equipment, information and communication equipment, etc.); hence, it do not take the use under the following special environments into consideration.

Accordingly, the use in the following special environments, and such environmental conditions may affect the performance of the product; prior to use, verify the performance, reliability, etc. thoroughly.

- 1) Use in liquids such as water, oil, chemical, and organic solvent.
- 2) Where the product is close to a heating component, or where an inflammable such as a polyvinyl chloride wire is arranged close to the product.
- 3) Where the product is sealed or coated with resin, etc.
- 4) Where water or a water-soluble detergent is used in cleaning free soldering (Pay particular attention to soluble flux.)
- 5) Use in such a place where the product is wetted due to dew condensation.
- 6) Use in places full of corrosive gases such as sea breeze, Cl₂, H₂S, NH₃, SO₂, and NO_X.
- 7) Use under direct sunlight, in outdoor or in dusty atmospheres.
- 8) Use in environment with large static electricity or strong electromagnetic waves.
- (6)If transient load (heavy load in a short time) like pulse is expected to be applied, carry out evaluation and confirmation test with resistors actually mounted on your own board. When the load of more than rated power is applied under the load condition at steady state, it may impair performance and/or reliability of resistor. Never exceed the rated power.
 - When the product shall be used under special condition, be sure to ask us in advance.
- (7)Halogen type (chlorine type, bromine type, etc.) or other high-activity flux is not recommended as the residue may affect performance or reliability of resistors.
- (8)When soldering with soldering iron, never touch the body of the chip resistor with a tip of the soldering iron. When using a soldering iron with a tip at high temperature, solder for a time as short as possible. (Three seconds or less up to 350 °C)
- (9)Avoid physical shock to the resistor and nipping of the resistor with hard tool (a pair of pliers or tweezers) as it may damage protective firm or the body of resistor and may affect resistor's performance.
- (10)Reflow soldering method shall apply to this product in principle.

Subject		Spec. No.
Chip Resistor Array	PRODUCT SPECIFICATION FOR INFORMATION	151-EXB-V8V01NE
Part No.		
	EXBV8V	9-7

11. Storage method

If the product is stored in the following environments and conditions, the performance and solderability may be badly affected. Avoid the storage in the following environments.

- (1) Storage in places full of corrosive gases such as sea breeze, Cl₂, H₂S, NH₃, SO₂, and NO_X.
- (2) Storage in places exposed to direct sunlight.
- (3) Storage in places outside the temperature range of 5 °C to 35 °C and humidity range of 45 %RH to 85 %RH.
- (4) Storage over a year after our delivery (This item also applies to the case where the storage method specified in item (1) to (3) has been followed.).

12. Laws and Regulations

- (1) No ODCs or other ozone-depleting substances that are subject to regulation under the Montreal Protocol are used in our manufacturing processes, including in the manufacture of this product.
- (2) This product complies with the RoHS Directive (Restriction of the use of certain Hazardous Substances in electrical and electronic equipment (DIRECTIVE 2002/95/EC)).
- (3) All materials used in this product are existing chemical substances recognized under "lows on examination of chemical substances and regulations of manufacturing and others."
- (4) None of the materials used in this product contain the designated incombustible bromic substances, PBBOs and PBBs.
- (5) Please contact us to obtain a notice as to whether this product has passed inspection under review criteria primarily based on Foreign Exchange and Foreign Trade Control Laws, and appended table in the Export Control Laws.

13. Production Place

Production Country: Japan

Production Plant : Panasonic Electronic Devices Japan Co., Ltd.

Production Country: China

Production Plant : Panasonic Electronic Devices (Tianjin) Co., Ltd. (PEDTJ)

Production Country: Malaysia

Production Plant : Panasonic Electronic Devices Malaysia Sdn. Bhd. (PEDMA)

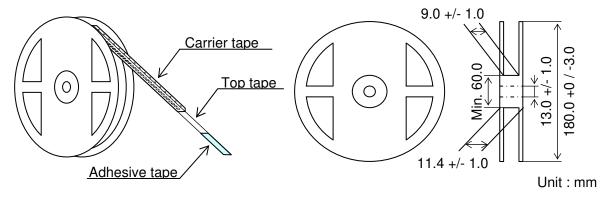
Subject		Spec. No.
Chip Resistor Array	PRODUCT SPECIFICATION FOR INFORMATION	151-EXB-V8V01NE
Part No.		
	EXBV8V	9-8

14. Tape and Reel Package

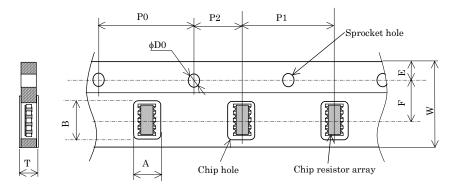
14-1. Physical Dimensions

Structure and reel dimensions shall be as shown in the figure below.

Inaccordance with EIAJ ET-7200.



14-2. Carrier Tape Dimensions



	A	В	W	F	E
(mm)	1.95±0.15	3.60±0.20	8.00±0.20	3.50 ± 0.05	1.75±0.10
	P1	P2	P0	${ m T}$	$\phi D0$
(mm)	4.00±0.10	2.00 ± 0.05	4.00±0.10	0.84 ± 0.05	$1.50^{+0.10}_{0}$

14-3. Specification

14-3-1. Taping

(1) When the test shall be operated with the below conditions, peel strength should be 0.049N to 0.49N, should not have flash and tear after peeling.



(2) Minimum Bending Radius

When carrier tape shall be bent by minimum bending radius (15 mm), no defection of chip and no break of carrier tape. However minimum bending radius shall be tested for 1 times.

Subject	Spec. No.
Chip Resistor Array PRODUCT SPECIFICATION	ON FOR INFORMATION 151-EXB-V8V01NE
Part No.	
EXBV8V	9-9

(3) Resistance to climate

When resistors shall be exposed at 60 °C \pm 2 °C, 90 %RH to 95 %RH for 120 hours, no defection of chip and no break off carrier tape.

When the top tape shall be peeled, tape should not have flash and tear.

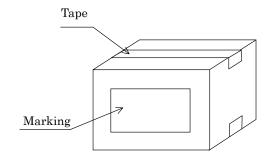
14-3-2. Quantity in Taping: 5,000 pcs. / reel

14-3-3. Tape packaging

- (1) Resistor side shall be facing upward.
- (2) Chip resistor shall not be sticking to top tape and bottom tape.
- (3) Chip resistors shall be easy to take out from carrier tape and chip hole or sprocket hole shall not have flash and break.

14-4. Outer Packaging

Quantity: 20 reels(Max.100,000 pcs.)



- (1) When packaging quantity does not reach max quantity, the remaining empty space shall be buried with buffer material.
- (2) When quantity shall be few, alternative packaging methods may used. No problem must occur during the exportation of the product..

14-5. Marking

At last, production country is displayed in English.

- Side of reel (Marking shall be on one side.)
 - (1)Part name (2)Part number (3)Quantity (4)Lot number (5)Maker name
 - (6)Production country
- Packaging box
 - (1)Customer name (2)Part name (3)Part number (4)Customer part number
 - (5)Quantity (6)Maker name (7) Production country

Subject	Spec. No.
Chip Resistor Array PRODUCT SPECIFICATION FOR INFORMATION	Attached Sheet
APPEARANCE QUALITY CRITERIA	1-1

Item	Defect Criteria	Appearance Criteria	Remark
Resin Chipping		A ≤ W/16 B ≤ C/2	Both side chipping shall be judged defect
Terminal Chipping	Through hole terminal chipping Oblique line show chipping	$A \le 1/2$ of radius $B \le T$ op terminal width $D \ge 1/2$ of radius Through hole's chipping area is within $1/4$ of through hole's area.	
Pin Hole		One pin hole / chip resistor $\phi \le 0.2 \text{ mm}$	This item is applied to pin holes which reach to the resistive materials
Flash	A A A A A A A A A A A A A A A A A A A	A ≤ 100 μm	